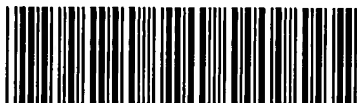


Search Notes



Application/Control No.

10/576,494

Examiner

John S. Chu

Applicant(s)/Patent under
Reexamination

HATTORI ET AL.

Art Unit

1752

SEARCHED

Class	Subclass	Date	Examiner
430	191	6/2007	JSC
430	192		
430	193		
430	18		
430	326		
430	330		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST SEARCH IN FILE	6/2007	JSC
INVENTOR SEARCH		